

Radiation measurement & comparison between VT and CM tests at cERL

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Contents about radiation measurement

- Radiation measurements at V.T by using T-X rotating mapping system.
- Radiation measurement at cERL cryomodule.
- Comparison between V.T and CM.

Based on TESLA cavity



modified

ERL model-2 9cell Nb cavities

Requirements of cERL main linac

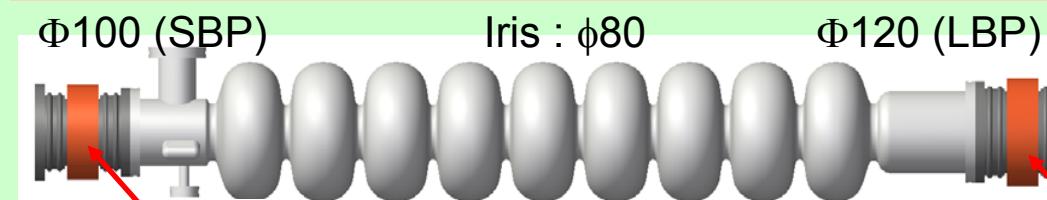
Frequency : 1.3 GHz

Gradient: 15MV/m

Q0: $>1 \times 10^{10}$

Beam current : max 100mA
(100mA (in) + 100mA(out))

ERL-model-2 cavity: 600mA can be circulated in design (HOM-BBU threshold)



H.Sakai et al., Proc. of ERL07 (2007).

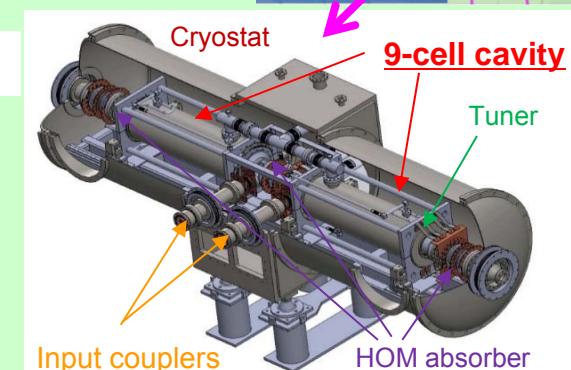
():TESLA cavity

Parameters of cERL main linac

Frequency	1300 MHz	Eacc	15-20MV/m
Q0	1e+10	Coupling	3.8 % (1.9%)
R_{sh}/Q	897 Ω (1007Ω)	$Q_o \times R_s$	289 Ω
E_p/E_{acc}	3.0 (2.0)	H_p/E_{acc}	42.5 Oe/(MV/m)

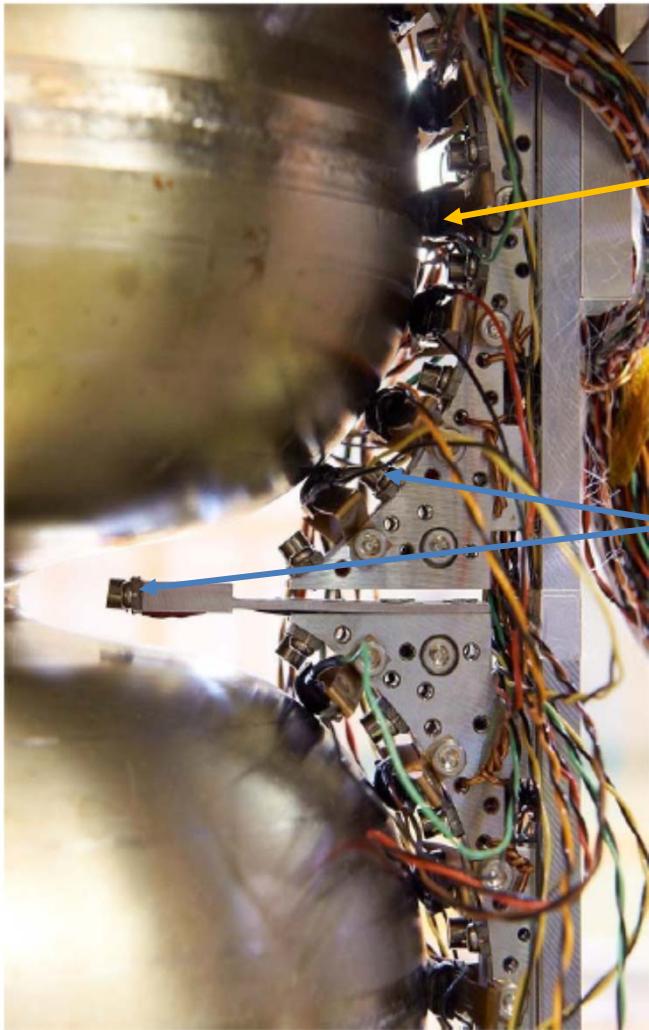
All HOMs damped to both end

Compact ERL (cERL) @KEK
Commissioning in 2013



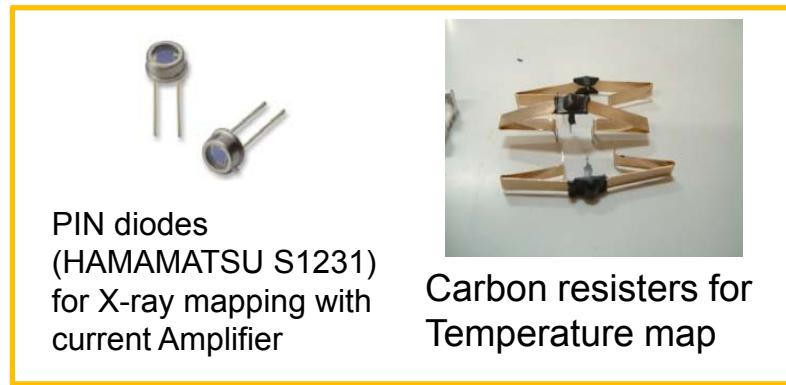
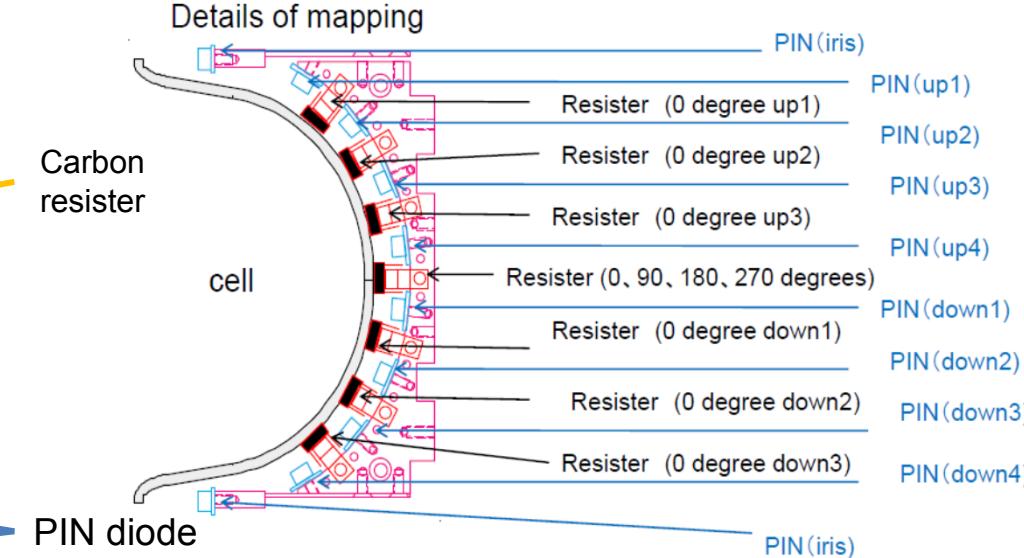
We need to see radiation information in detail → motivation for x-ray rotating mapping

X-T Rotating mapping system for radiation measurement at VT



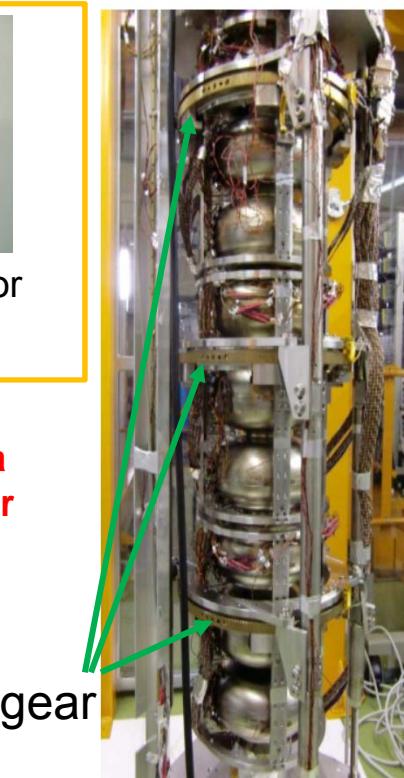
82 PIN diodes and 93 Carbon resistors are mounted on the mapping system along a meridian to detect **9cell radiation and temperature mapping precisely**

H.Sakai et al., Proc. of IPAC 2010 ,p2950

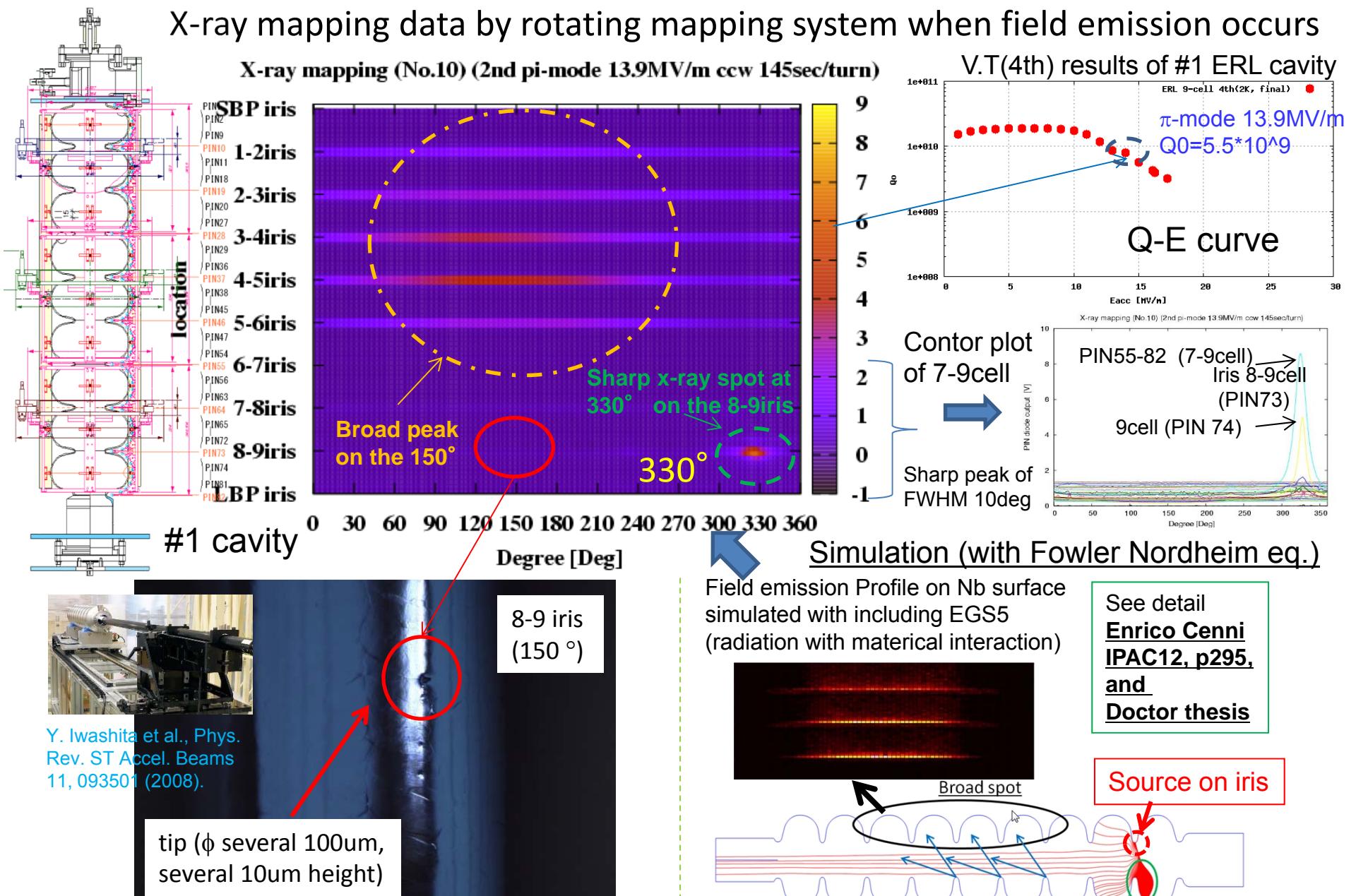


The sensor array can turn around the cavity surface using stepping motors via gear and data taking every 0.5s by logger

Figures of merit
(compared with fix mapping)
• Resolution 0.5°
• Small number of sensors



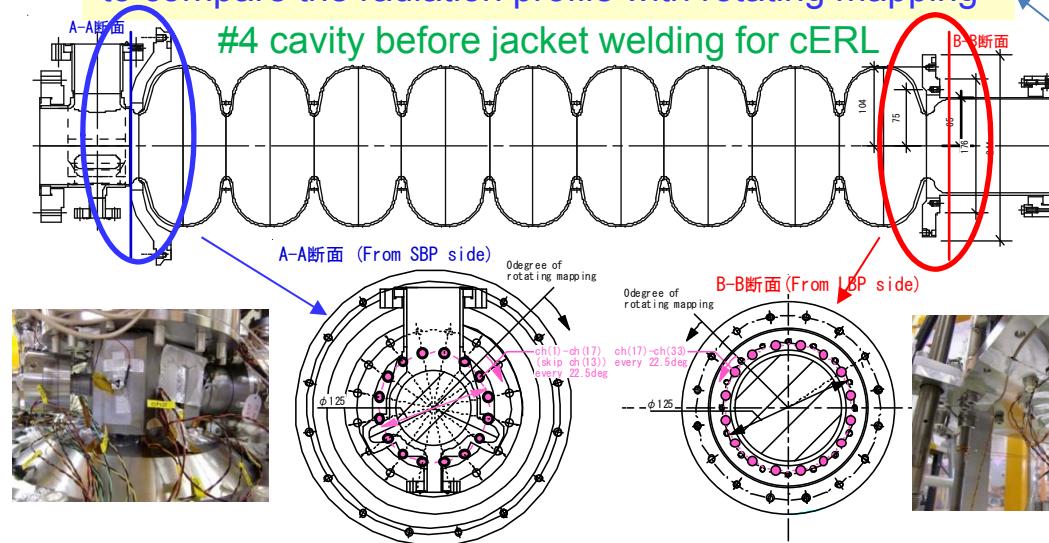
X-ray mapping data by rotating mapping system when field emission occurs



We found clear X-ray profile (broad & sharp) by rotating mapping system. → powerful tool for radiation source search
Tip were observed opposite side of x-ray sharp peak.

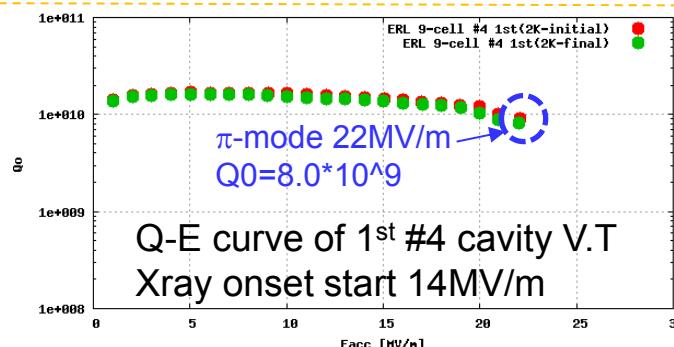
Measured profile were clearly explained by simulation .
We can know the localized source of field emission in V.T

Ring 16 PIN diodes were set on both jacket sides to compare the radiation profile with rotating mapping

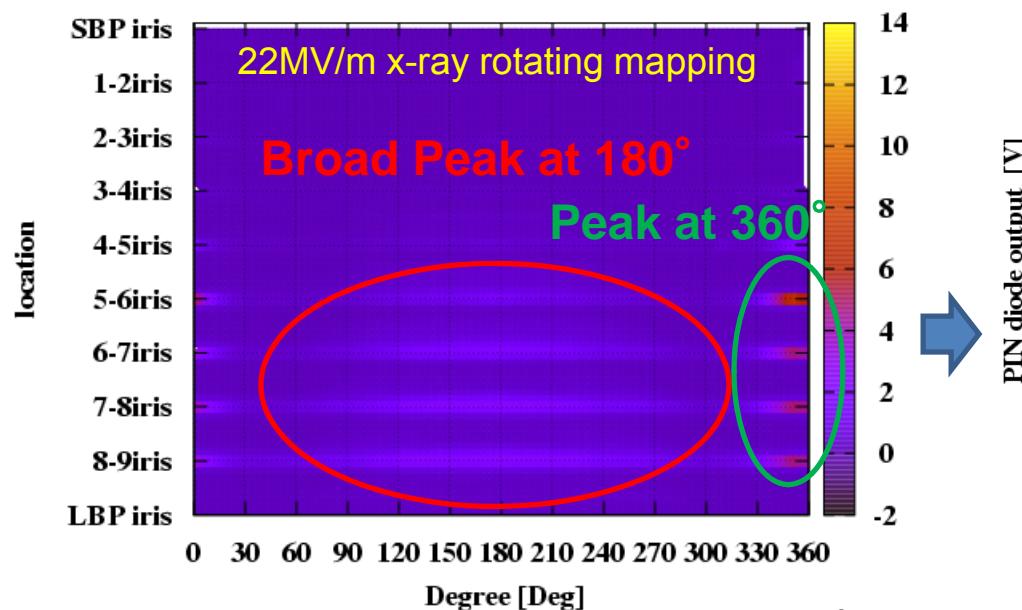


How to know the profile and radiation source on cryomodule test ?

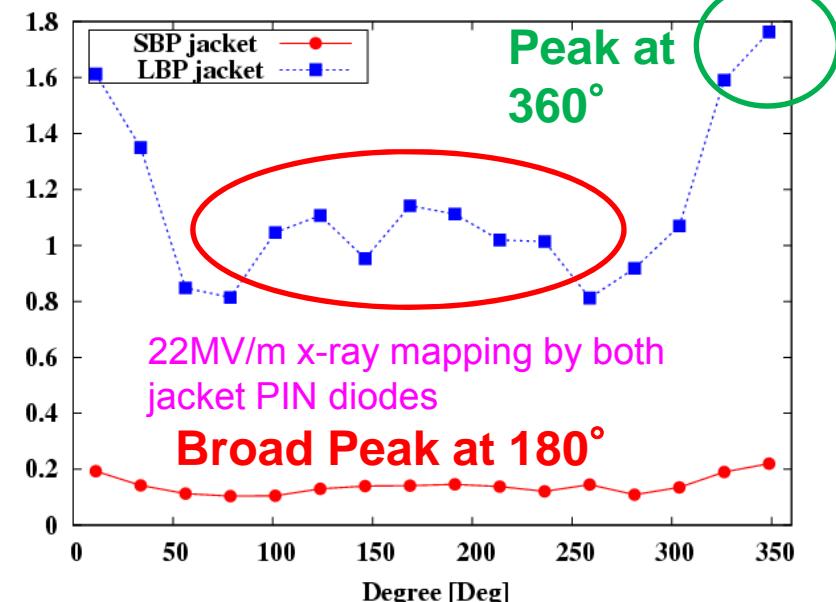
Field emission (F.E) electron run along cavity axis. We think angular distribution of F.E preserved and detected outside of jacket near both end.



pi-mode_2 22MV/m, $Q_0=8.0 \times 10^9$, Ploss=76W



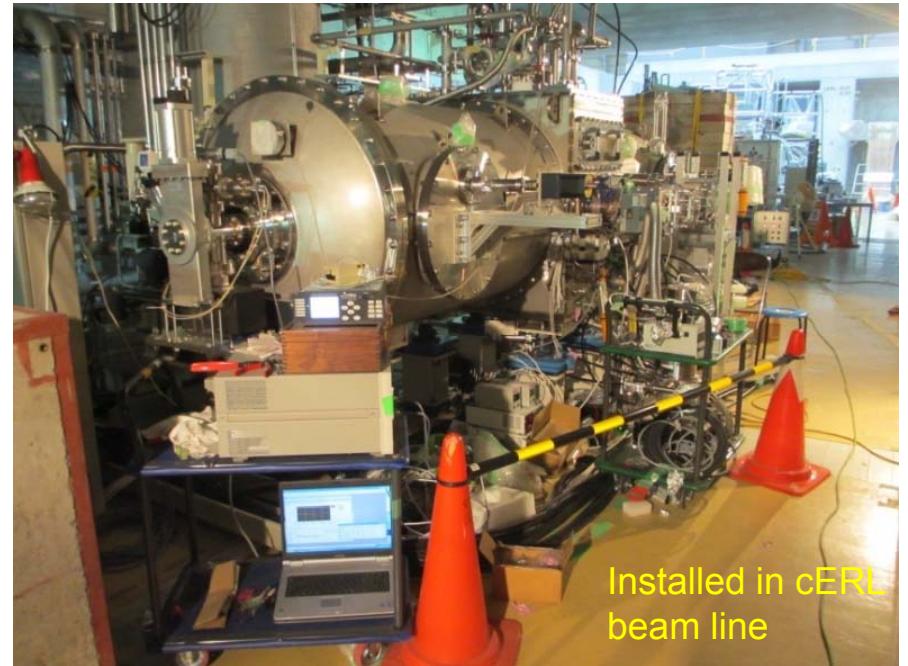
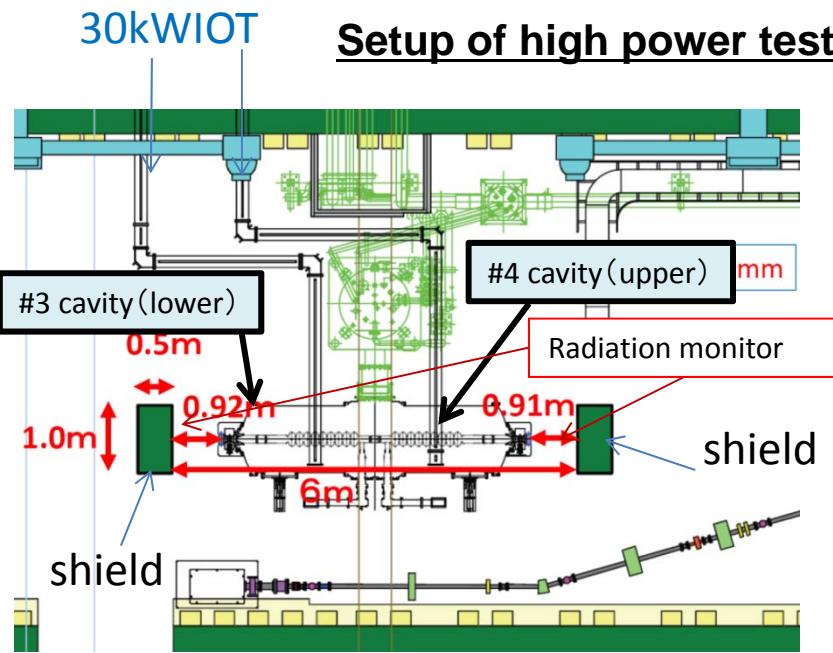
pi-mode_2 22MV/m, $Q_0=8.0 \times 10^9$, Ploss=76W



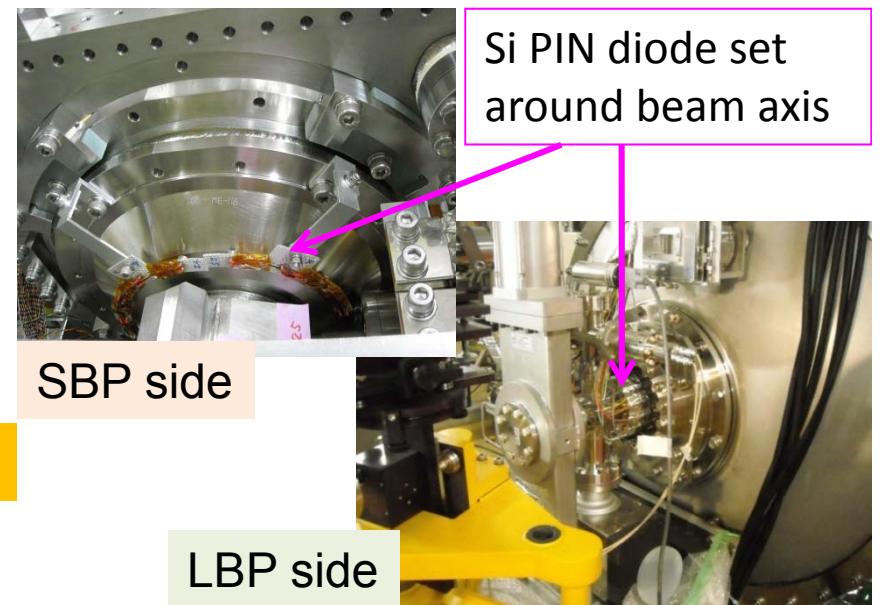
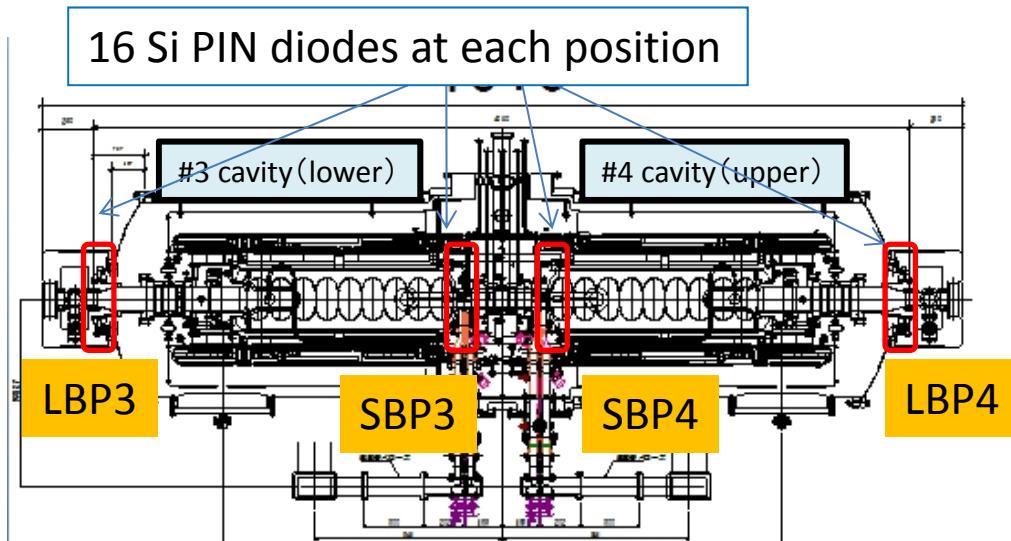
Radiation profile were detected from both direction by a ring of 16 PIN diodes and agree well with x-ray angular distribution of rotating mapping.

16 PIN can detect radiation profile during cryomodule test.

Setup of high power test at cERL-ML cryomodule

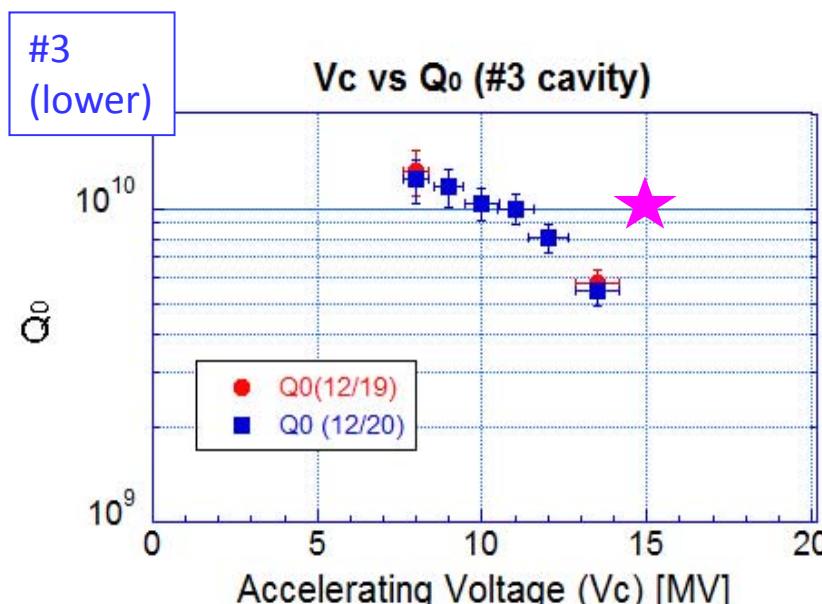
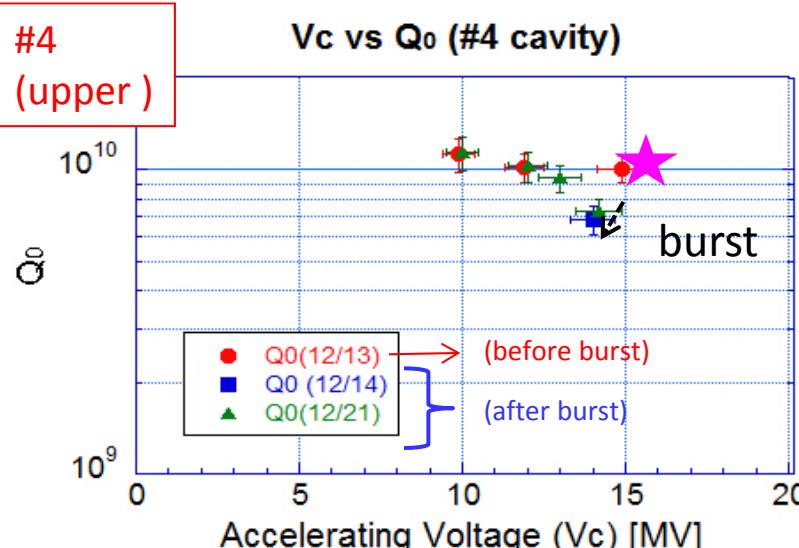


PIN radiation profile monitor set around beam axis



Upper QL : 1.54×10^7
 Lower QL : 1.15×10^7

Max input power
 (Pin) is 5kW during
 high power test

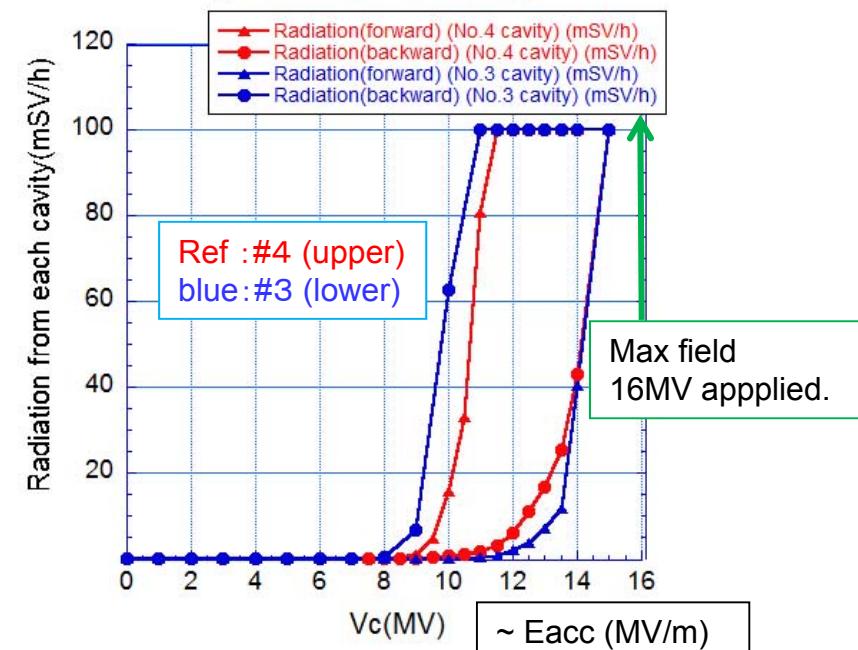


★ : Requirement of cERL

Results of high power test (V_c vs Q₀)

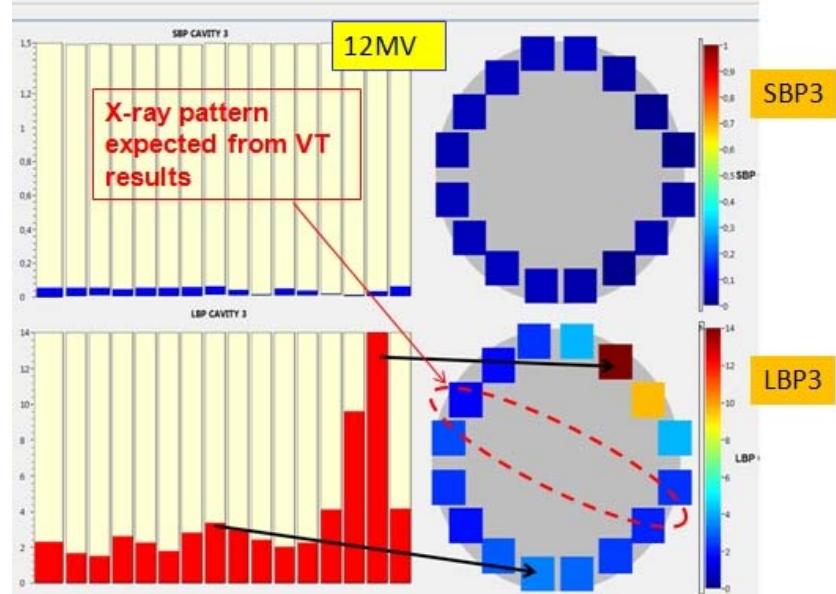
- High power test was done one by one cavity.
- Input coupler was processed up to 25kW before high power test.
- Both cavities reached to V_c = 16MV.
- Q₀ of #4 cavity decreased during processing.
- Field emission on-set was 8-9 MV for both cavities.

Measured radiation of each
 cavities at final state

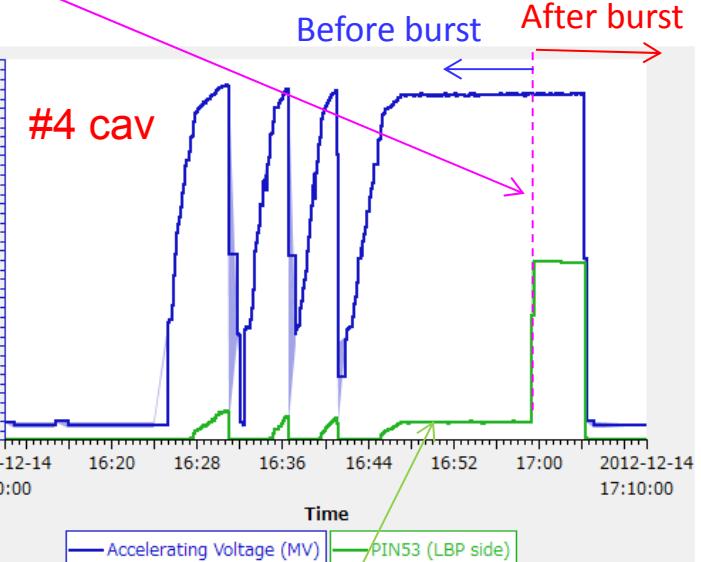


Detail radiation profile measurement

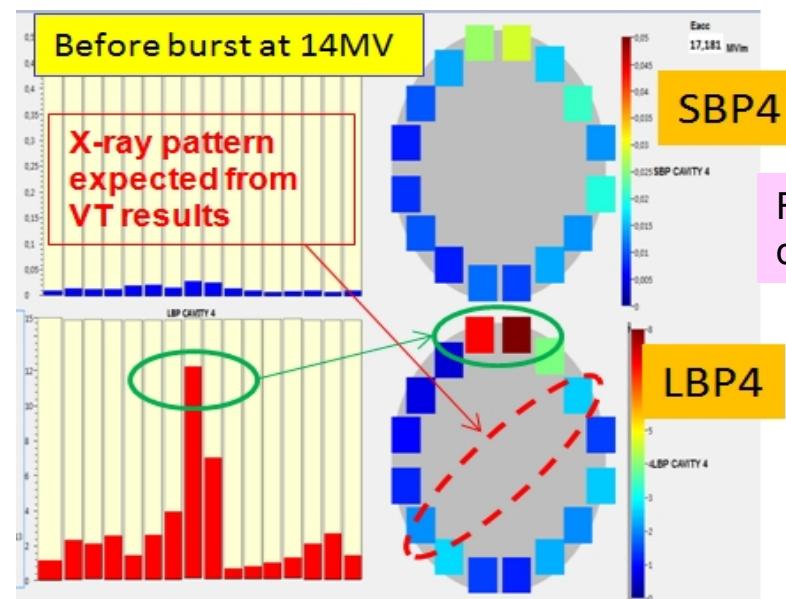
#3
(lower)



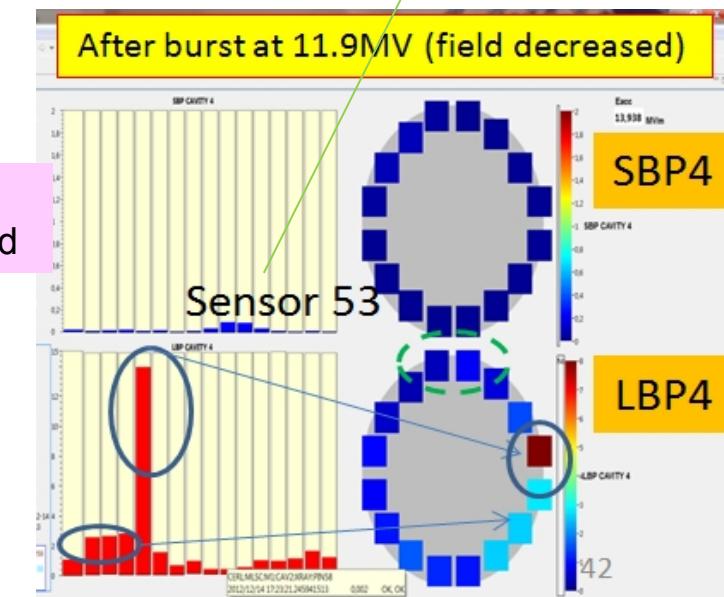
Sudden burst event was observed under keeping field of 14.5MV



#4
(upper)



Field decreased

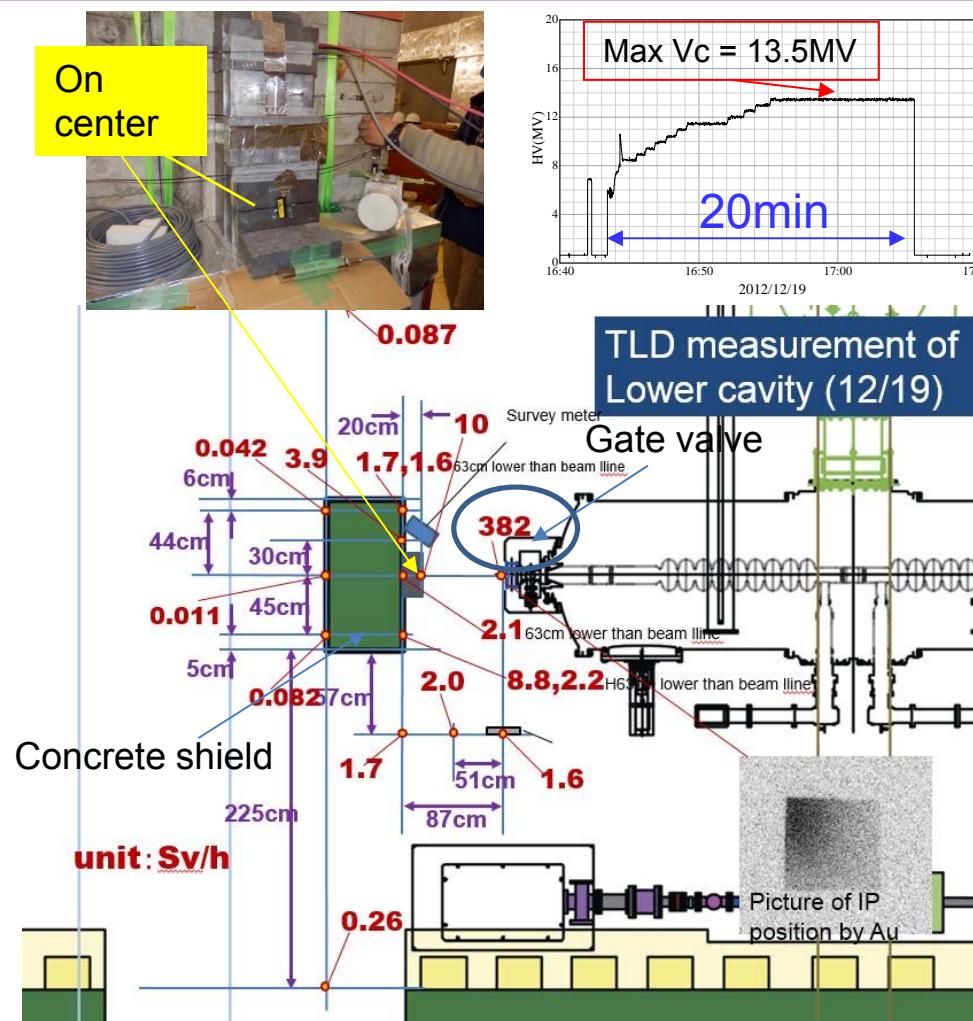


- Radiation pattern was changed from V.T
- Radiation pattern also changed after X-ray burst

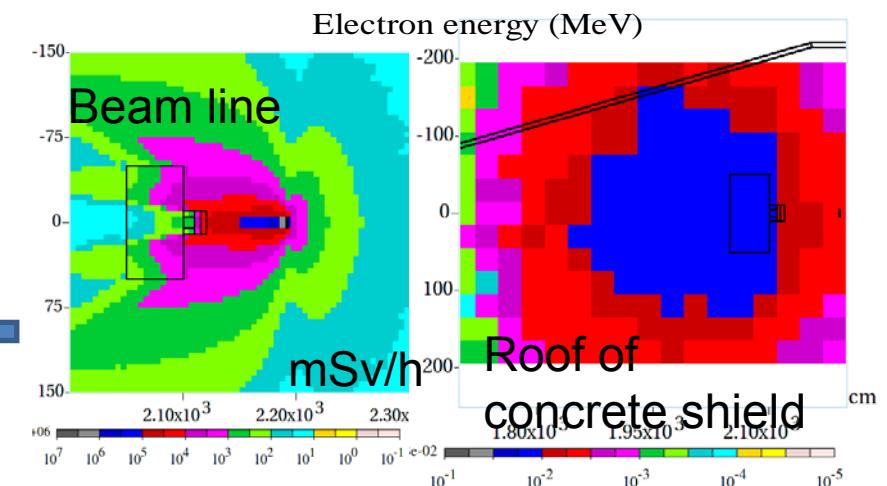
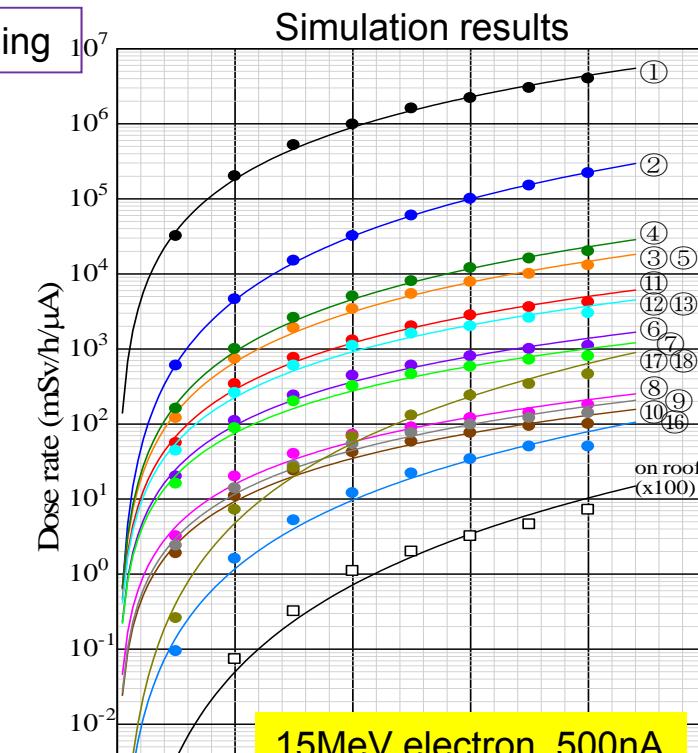
- Another new radiation sources were produced during assembly work and high power test.

Dose measurement and simulation by MRAS15

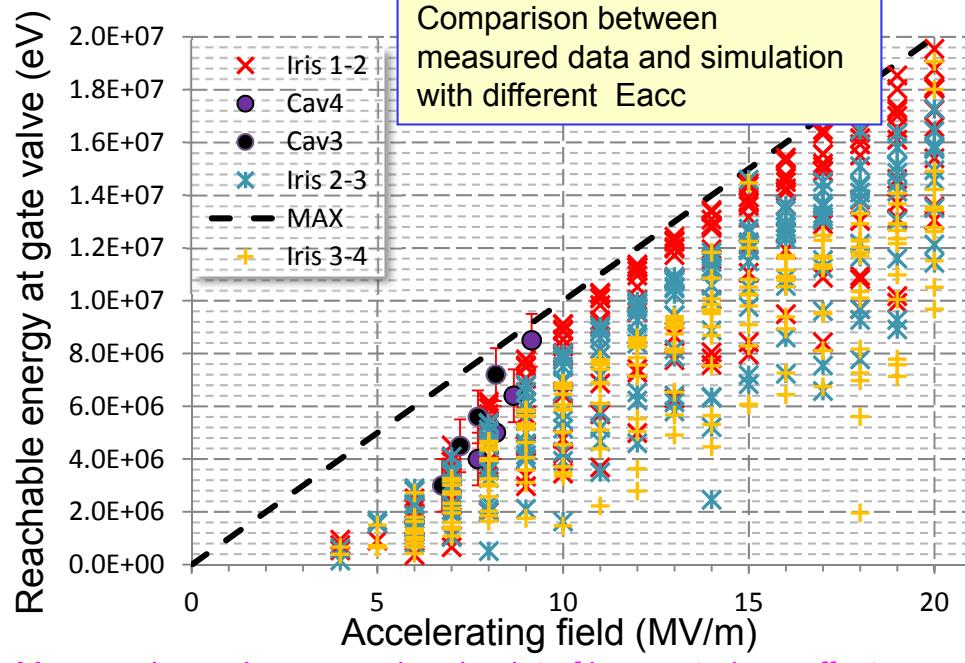
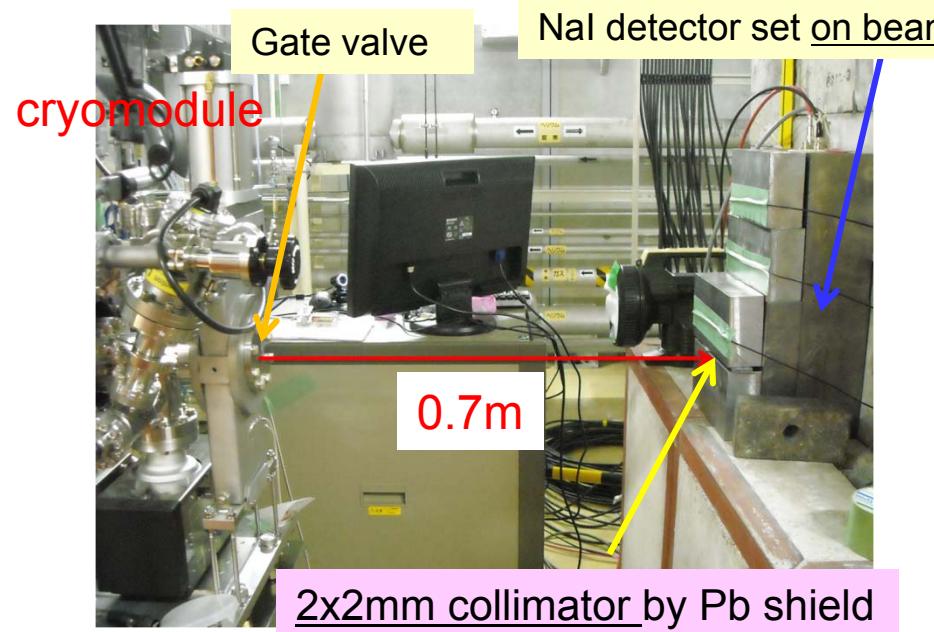
Measured dose by TLD on about 20 positions under 13.5MV keeping



Coatesy by H.Matsumura

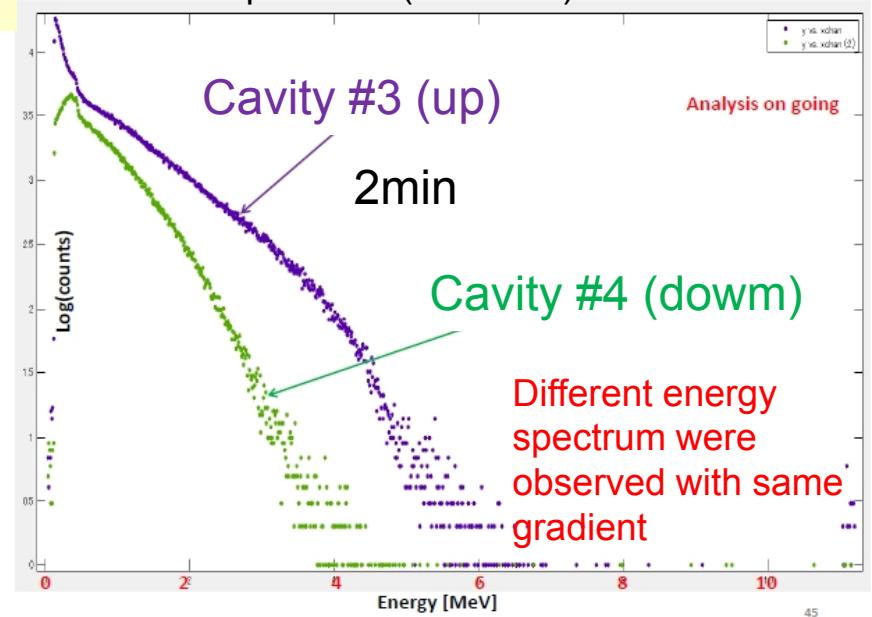


Survey location of field emission source by NaI

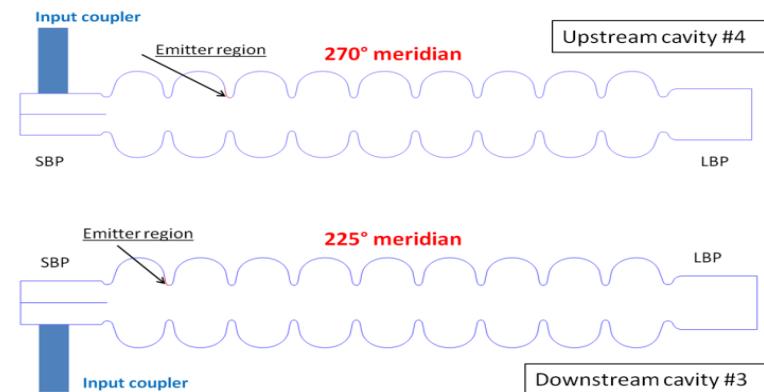


Enrico Cenni et al., TUP091 in SRF2013

Measured spectrum (at 8.5MV)



Estimated source position

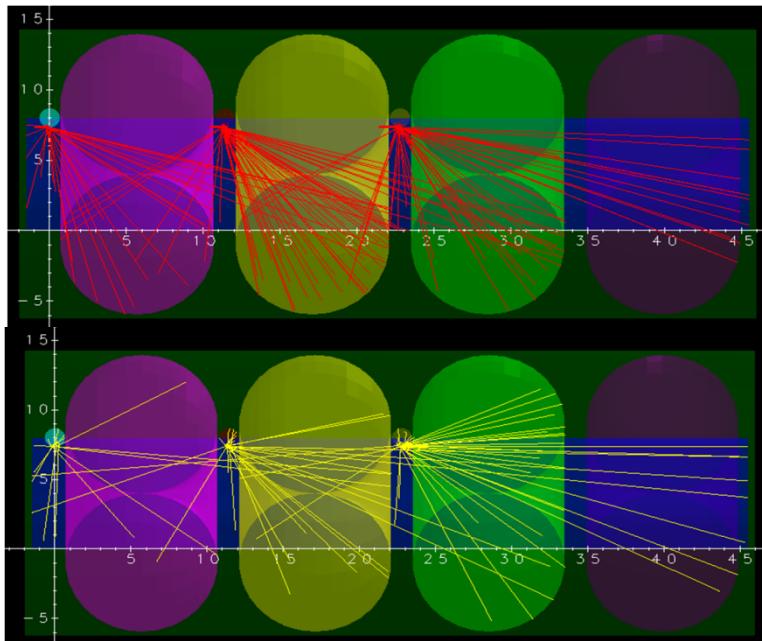


Position near SBP and input port is estimated as a radiation source. String assembly work was poor near SBP side ?? Coupler also caused the burst ??

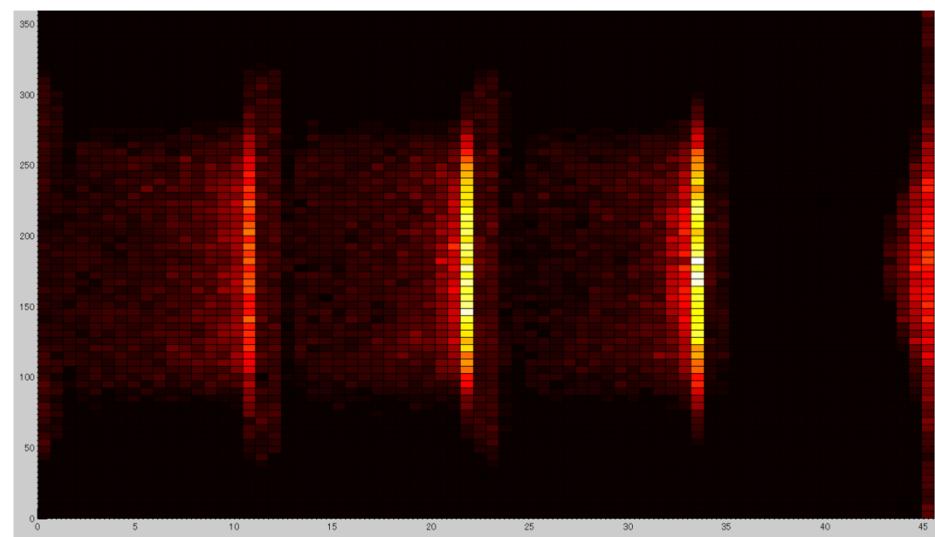
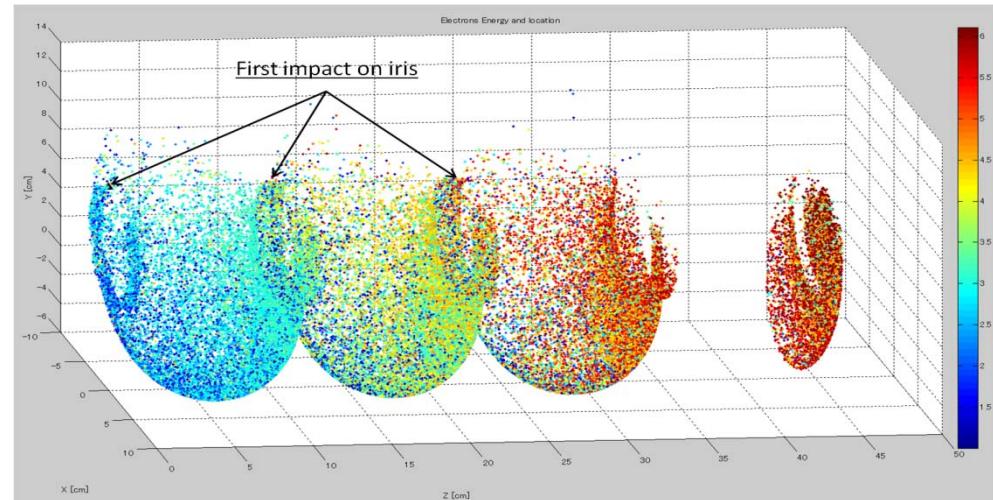
Backup

Radiation calculation (EGS5)

electron



photon



Compact ERL(cERL) at KEK

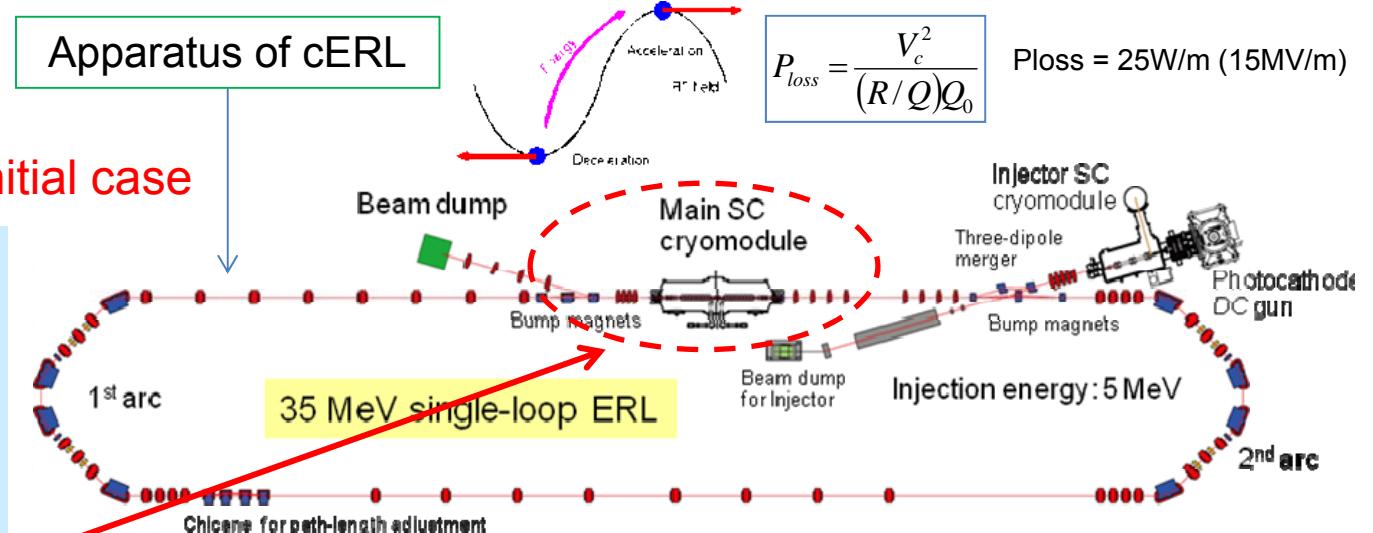
Current : 10-100mA
 Emittance : 0.1-1 mm mrad
 Bunch length : 0.1-3ps

cERL parameters Red: initial case

Requirements of cERL main linac

Frequency : 1.3 GHz
 Gradient: 15MV/m
 $Q_0: > 1 \times 10^{10}$
 Beam current : max 100mA
 (100mA (in) + 100mA(out))

Apparatus of cERL



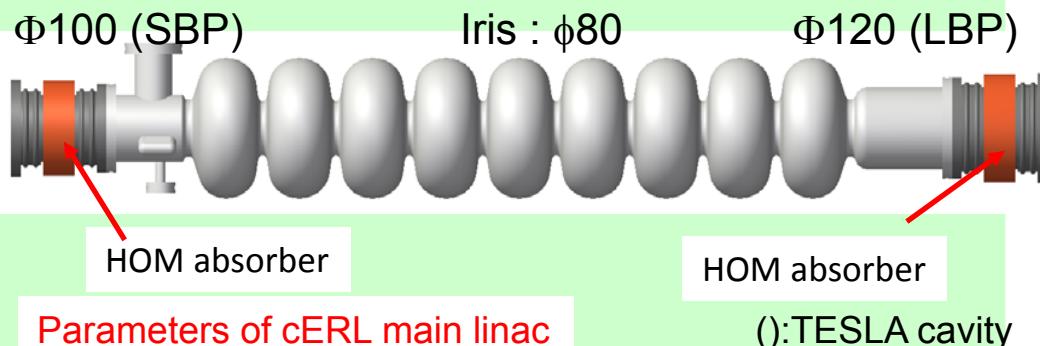
$$P_{loss} = \frac{V_c^2}{(R/Q)Q_0}$$

Ploss = 25W/m (15MV/m)

ERL-model-2 cavity: 600mA can be circulated in design

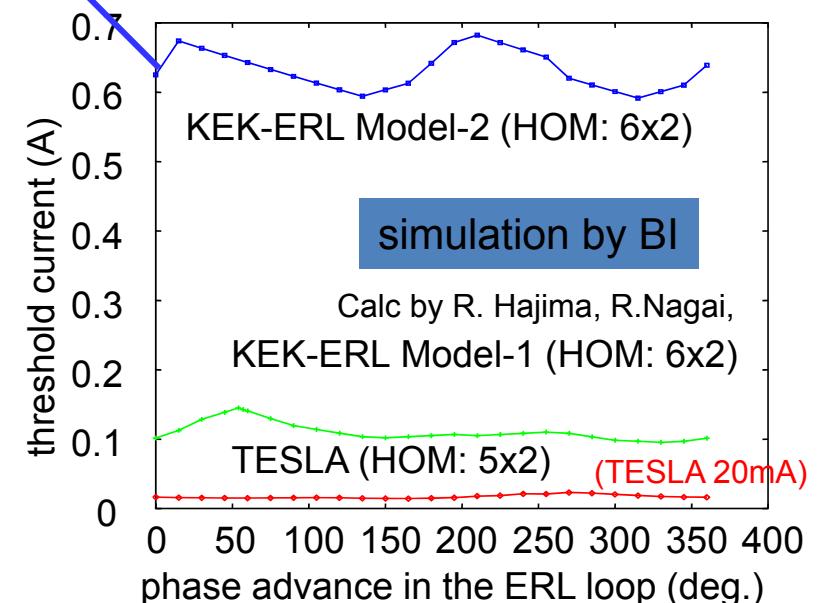
H.Sakai et al., Proc. of ERL07 (2007). All HOMs damped to both end

HOM-BBU calculation (w/o HOM randomization)



Parameters of cERL main linac

Frequency	1300 MHz	Eacc	15-20MV/m
Q0	1e+10	Coupling	3.8 % (1.9%)
R_{sh}/Q	897 Ω (1007Ω)	$Q_0 \times R_s$	289 Ω
E_p/E_{acc}	3.0 (2.0)	H_p/E_{acc}	42.5 Oe/(MV/m)



Compact ERL main linac cryomodule configuration



9cell superconducting cavity
 $Q_0 > 1 \times 10^{10}$ @15MV/m

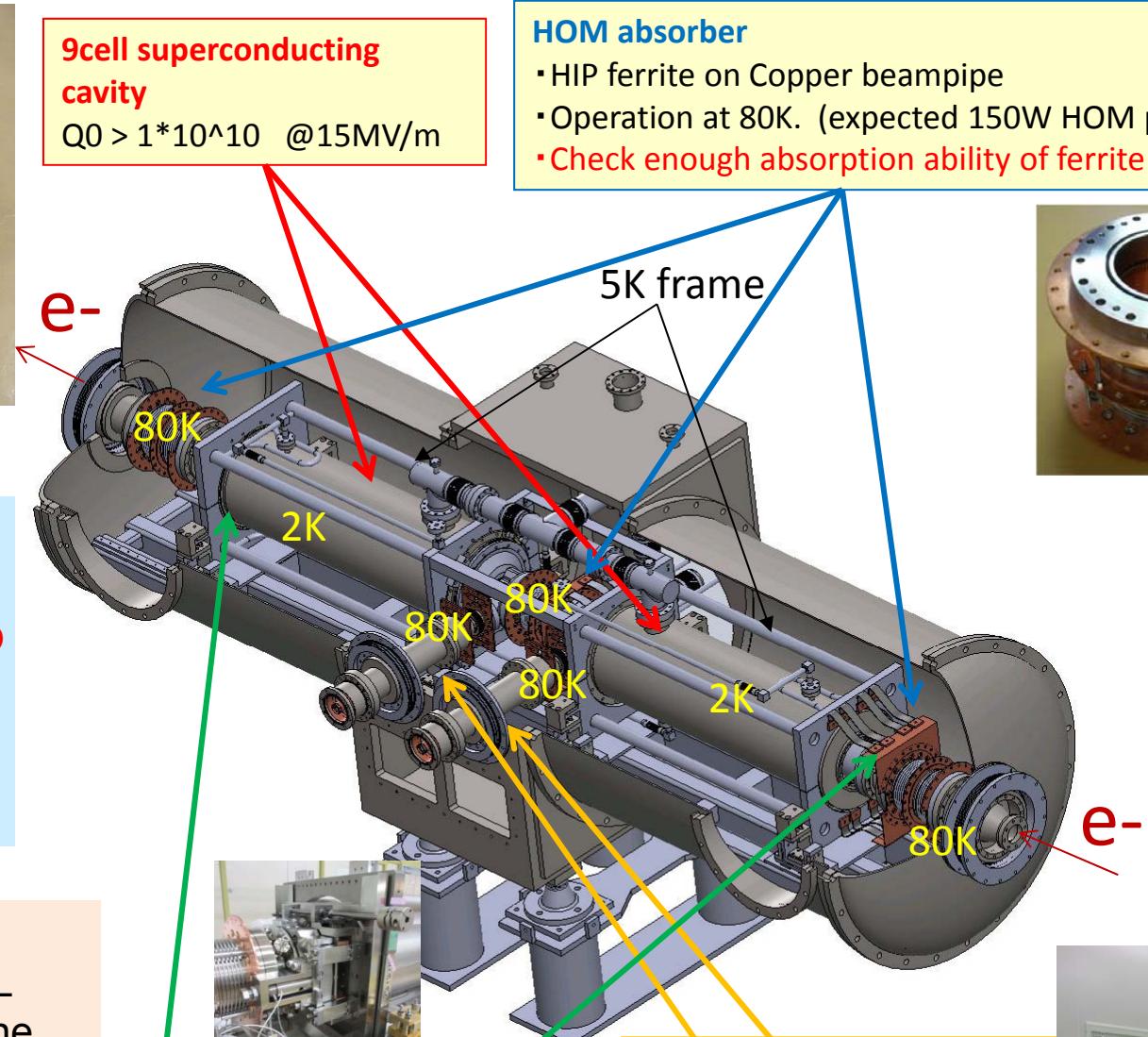
HOM absorber

- HIP ferrite on Copper beampipe
- Operation at 80K. (expected 150W HOM power)
- Check enough absorption ability of ferrite at 80K



(Compact) ERL target

Frequency : 1.3 GHz
Input power : 20kW CW (SW)
Gradient: 15MV/m
 $Q_0: > 1 \times 10^{10}$
Beam current : max 100mA
(against HOM-BBU instability)



2-cavity cryomodule was developed for compact ERL main linac to demonstrate the high current ERL operation at cERL. We have done the high power test by using this cryomodule.

Frequency Tuner
Slide jack tuner (mechanical)
piezo tuner(fine tuning)



Input coupler

- 20kW CW (standing wave)
- Cold and warm window
- HA997 ceramic is used
- $QL = (1-4) \times 10^7$ (variable)

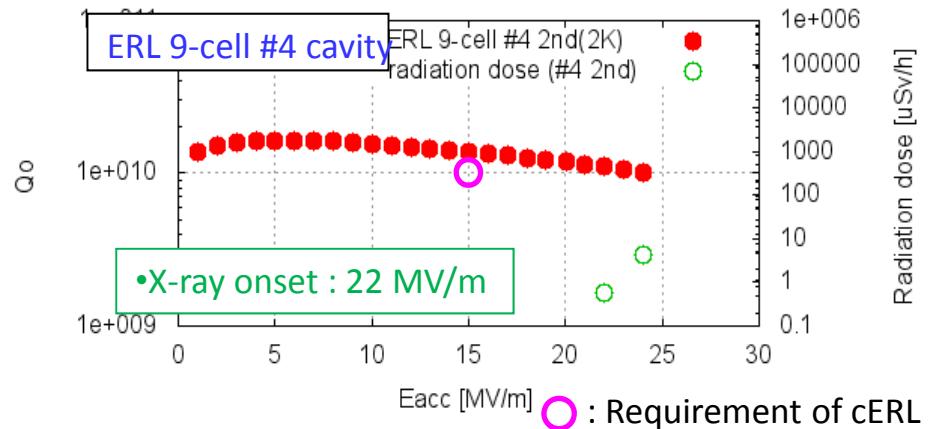
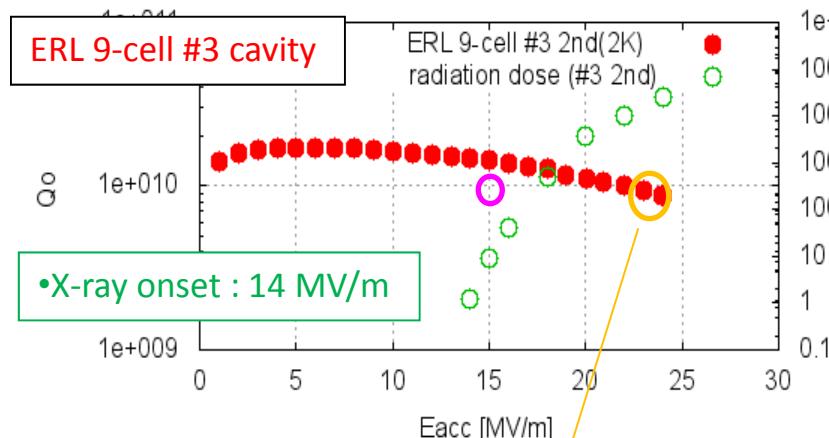


Results of vertical test of cERL Main linac two cavities

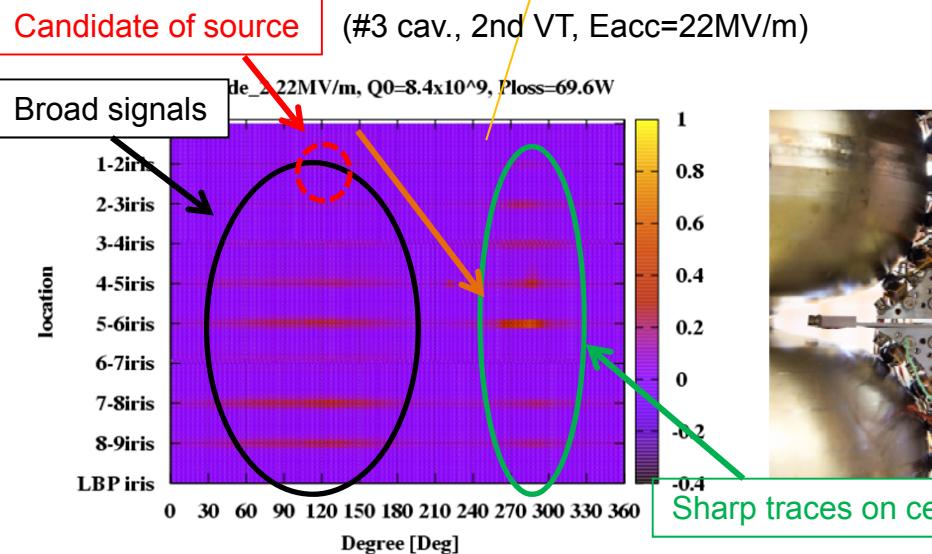
Carried out V.T of 2 ERL-model-2 cavities for cERL in 2011.
 Achieve 25MV/m (administrative limit) :
 Satisfy cERL requirement : $Q_0 > 1 \times 10^{10} \text{ at } 15 \text{ MV/m}$

K.Umemori et al., Proc. of IPAC12, p2227

For module assembly



Field emission profile by rotating X-ray mapping

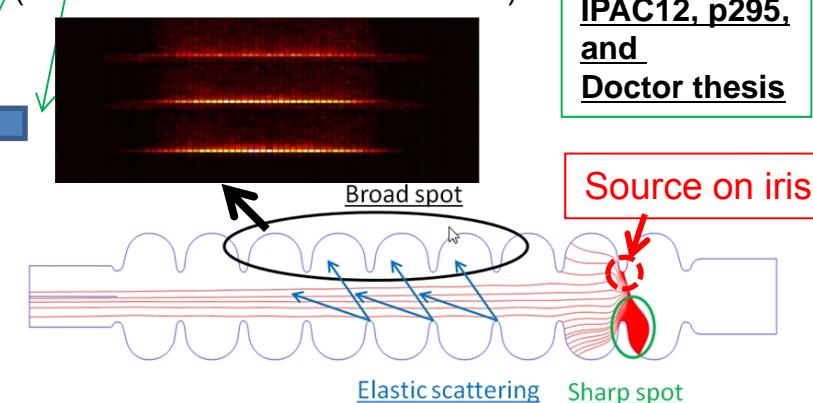


H.Sakai et al., Proc. of IPAC 2010 ,p2950

Simulation (with Fowler Nordheim eq.)

PIN diode
 Field emission Profile on Nb surface simulated with including EGS5
 (radiation with material interaction)

See detail
Enrico Cenni
IPAC12, p295,
and
Doctor thesis



Measured profile were clearly explained by simulation . 14
 We can know the localized source of field emission in V.T